

# **Power Double Lock Connector System**

#### 1. **SCOPE**

#### 1.1. Content

This specification covers performance, tests, and quality requirements for the Power Double Lock Connector System.

#### Qualification 1.2.

When tests are performed on the subject product line, procedures specified in Figure 1 shall be used. All inspections shall be performed using the applicable inspection plan and product drawing.

#### 1.3. **Qualification Test Results**

Successful qualification testing on the subject product line was completed between 22Nov94 and 20Oct95. The Qualification Test Report number for this testing is 501-5146. Additional successful qualification testing on the subject product line was completed between 08Aug95 and 14Oct95. The Qualification Test Report number for this testing is 501-5169.

#### 1.4. **Revision Summary**

Revisions to this specification include:

- Updated voltage rating
- Add W-T-B current rating on Figure 7.

### 2. APPLICABLE DOCUMENTS AND FORMS

The following documents form a part of this specification to the extent specified herein. Unless otherwise specified, the latest edition of the document applies. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

#### 2.1. TE Connectivity Specifications

114-5175	Application Specification – Power Double Lock Connector System
501-5146	Qualification Test Report – Power Double Lock Connector System (Wire to Wire)
501-5169	Qualification Test Report – Power Double Lock Connector System (Wire to Board)

#### 2.2. Commercial Standards and Specifications

IEC 60512	International Standard – Connectors for Electronic Equipment – Tests and Measurements
EIA-364	Electrical Connector/Socket Test Procedures Including Environmental

Electrical Connector/Socket Test Procedures Including Environmental

Classifications

#### 2.3. Reference Documents

109-1	General Requirements for Testing
102-950	Qualification of Separable Interface Connectors

### 3. REQUIREMENTS

#### 3.1. **Design and Construction**

Product shall be of the design, construction, materials and physical dimensions specified on the applicable product drawing.



### 3.2. Materials

Materials used in the construction of this product shall be as specified on the applicable TE drawing.

# 3.3. Ratings

A. Voltage Rating: 300 VAC/VDC

B. Current Rating: See Figure 6, Figure 7, Figure 8 and Figure 12

C. Temperature Rating: -30°C to +105°C (includes ambient temperature plus thermal increase due to current flow)

D. Minimum Ratings: 1 mV, 1 µA (minimum)

E. Applicable PCB

Thickness: 1.6 mmDiameter of Hole:

o For Tine: 1.25±0.05 (punched hole), 1.40±0.05 (drilled hole)

o For Boss: 2.20±0.05 (punched hole and drilled hole)

## 3.4. Performance Requirements and Test Description

The product should meet the electrical, mechanical and environmental performance requirements specified in Figure 1. All tests shall be performed at ambient environmental conditions otherwise specified.

# 3.5. Test Requirements and Procedure Summary

Test Description	Requirement	Procedure			
Examination of Product	Meets requirements of product drawing and application specification (114-5175). After testing, parts shall show no damage of physical change detrimental to product performance.	EIA-364-18 Visually inspected per applicable inspection plan. Precondition parts for 24 hours prior to testing.			
	Electrical				
Termination Resistance (Low Level Contact Resistance)	Initial: 10 m $\Omega$ (maximum) Final: 20 m $\Omega$ (maximum)	EIA-364-23  Measure as per the connection in Figure 2 and Figure 3. Subtract the bulk resistance of the wire from the measurement. (Protect wire from corrosion during testing.) Test on mated connector.  Test Current: <100 mA  Test Voltage: <20 mV			
Insulation Resistance	Initial: 1000 M $\Omega$ (minimum) Final: 500 M $\Omega$ (minimum)	EIA-364-21 Apply 500 VDC and hold for 2 minutes. Test between contacts in adjacent circuits and between housing and contacts in a mated connector.			
Dielectric Withstanding Voltage	1 minute hold without a creep discharge or flashover.  Current Leakage: 5 mA (maximum)	EIA-364-20, Method A, Condition 1 Hold at 2.2 kV AC at sea level for 1 minute. Current Leakage: 5 mA (maximum) Test between contacts in adjacent circuits and between housing and all contacts in a mated connector.			

Figure 1 (continued)

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Temperature Rise vs. Current	30°C maximum when subjected to rated	EIA-364-70, Method 1				
	current	Measure the temperature rise above ambient created by the energizing current.  Measurement must be taken at a place where there is no influence from air convection.  Contacts to be assembled in housing with all circuits connected. The thermocouple is to be attached to the contact in the center circuit.				
		Stabilize at a single current level until 3 readings at 5 minute intervals are within 1°C.				
		See Figure 2, Figure 3, Figure 6, Figure 7, Figure 8 and Figure 12.				
	Mechanical					
Sinusoidal Vibration	No electrical discontinuity greater than 1 μs	EIA-364-28, Condition I				
	shall occur.  No physical damage that would impair product performance.	Subject mated connector to 10-55-10 Hz traversed in 1 minute at 1.52 mm amplitude. Apply 2 hours in each of 3 mutually perpendicular planes. 100 mA applied.				
Random Vibration	No electrical discontinuity greater than 1 μs	EIA-364-28, Test Condition VII, Level D				
	shall occur.  No physical damage that would impair product performance.	Subject mated connector to 3.10G's RMS between 20 and 500 Hz. Apply 15 minutes in each of 3 mutually perpendicular planes. See Figure 4.				
Mechanical Shock	No electrical discontinuity greater than 1 μs	EIA-364-27, Condition A				
	shall occur.  No physical damage that would impair product performance.	Subject mated connector to 50G's half-sine shock pulse of 11 ms duration. 3 drops each to normal and reversed directions of X, Y and Z axis. Total of 18 drops. See Figure 4.				
Connector Mating Force	Normal Type: (6.86 x # of Positions) N	EIA-364-13, Method A				
	(maximum)	Operation Speed: 100 mm/min				
	High Pressure Type: (9.8 x # of Positions) N (maximum)	Measure the force required to mate connector without locking latches.				
Connector Unmating Force	Normal Type: (1.47 x # of Positions) N	EIA-364-13, Method A				
	(minimum)	Operation Speed: 100 mm/min				
	High Pressure Type: (1.96 x # of Positions) N (minimum)	Measure the force required to unmate connectors without locking latches.				
Contact Insertion Force	6.86 N (maximum) per contact	EIA-364-5				
		Measure the force required to insert contact into housing.				
Contact Retention Force	41.16 N (minimum)	EIA-364-29, Method A				
		Operation Speed: 100 mm/min				
		Measure the axial force required to remove contact crimped to 16 AWG or 18 AWG wire from the housing.				
Contact Mating Force	Normal Type: 6.86 N (maximum)	EIA-364-37, Method A				
	High Pressure Type: 9.8 N (maximum)	Operation Speed: 100 mm/min				
		Measure force required to mate contact to gage tab per dimensions in Figure 5.				

Figure 1 (continued)

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(AWG [mm²]) (minimum) (N [kgf])   CA   CB   CB   CB   CB   CB   CB   CB	ΓE customer drawing.				
26 [0.14]   19.6 [2]   24 [0.22]   29.4 [3]     22 [0.31]   49.0 [5]     20 [0.51]   58.8 [6]     18 [0.87]   68.6 [7]     16 [1.27]   78.4 [8]	Apply an axial pull force to the crimped wire.  Contact to be secured to the tester. Insulation parrel crimp to be disabled.  EIA-364-9  Manually mate and unmate connectors for 25 cycles.  EIA-364-97  Operation Speed: 100 mm/min.  Measure panel retention force using a panel cut with nominal dimensions as specified in the TE customer drawing.				
Durability   Durability   Durability   Durability   Durability   Durability   Durability   Durability   No physical damage that would impair product performance.   Durability   Parallel   Durability   Parallel   Durability   Durability   Durability   No physical damage that would impair product performance.   Durability   Dura	Dearrel crimp to be disabled.  EIA-364-9  Manually mate and unmate connectors for 25 cycles.  EIA-364-97  Operation Speed: 100 mm/min.  Measure panel retention force using a panel cut with nominal dimensions as specified in the TE customer drawing.				
22 [0.31]	EIA-364-9  Manually mate and unmate connectors for 25 cycles.  EIA-364-97  Operation Speed: 100 mm/min.  Measure panel retention force using a panel cut with nominal dimensions as specified in the TE customer drawing.				
20 [0.51]   58.8 [6]	Manually mate and unmate connectors for 25 cycles.  EIA-364-97  Operation Speed: 100 mm/min.  Measure panel retention force using a panel cut with nominal dimensions as specified in the TE customer drawing.				
18 [0.87] 68.6 [7] 16 [1.27] 78.4 [8]  Durability  No physical damage that would impair product performance.  Housing Panel Retention Force  98 N (minimum)  Environmental  Environmental	Manually mate and unmate connectors for 25 cycles.  EIA-364-97  Operation Speed: 100 mm/min.  Measure panel retention force using a panel cut with nominal dimensions as specified in the TE customer drawing.				
To [1.27] 78.4 [8]  No physical damage that would impair product performance.  Housing Panel Retention Force 98 N (minimum)  Construction of the product performance of the product per	Manually mate and unmate connectors for 25 cycles.  EIA-364-97  Operation Speed: 100 mm/min.  Measure panel retention force using a panel cut with nominal dimensions as specified in the TE customer drawing.				
Durability  No physical damage that would impair product performance.  Housing Panel Retention Force  98 N (minimum)  Environmental  Post Retention Force  19.6 N (minimum)  Environmental	Manually mate and unmate connectors for 25 cycles.  EIA-364-97  Operation Speed: 100 mm/min.  Measure panel retention force using a panel cut with nominal dimensions as specified in the TE customer drawing.				
Post Retention Force  product performance.  Most results of the performance of the product performance.  Most results of the performance of the pe	Manually mate and unmate connectors for 25 cycles.  EIA-364-97  Operation Speed: 100 mm/min.  Measure panel retention force using a panel cut with nominal dimensions as specified in the TE customer drawing.				
Housing Locking Strength  2P-4P Housing: 34.3 N (minimum) 6P, 8P, 9P, 10P, 12P: 44.1 N (minimum) E Post Retention Force  19.6 N (minimum)  Environmental	Operation Speed: 100 mm/min.  Measure panel retention force using a panel cut with nominal dimensions as specified in the TE customer drawing.				
Housing Locking Strength  2P-4P Housing: 34.3 N (minimum) 6P, 8P, 9P, 10P, 12P: 44.1 N (minimum) E Post Retention Force  19.6 N (minimum)  Environmental	Measure panel retention force using a panel cut with nominal dimensions as specified in the TE customer drawing.				
Housing Locking Strength  2P-4P Housing: 34.3 N (minimum)  6P, 8P, 9P, 10P, 12P: 44.1 N (minimum)  E  Post Retention Force  19.6 N (minimum)  Environmental	cut with nominal dimensions as specified in the TE customer drawing.				
6P, 8P, 9P, 10P, 12P: 44.1 N (minimum)  Control Post Retention Force  19.6 N (minimum)  Environmental	=IΔ-364-98				
Post Retention Force 19.6 N (minimum) E  Environmental	EIA-364-98				
Post Retention Force 19.6 N (minimum) E  C  Environmental	Operation Speed: 100 mm/min				
Environmental	Ensure that locking latches are fully engaged.				
Environmental Environmental	EIA-364-29				
Environmental	Operation Speed: 100 mm/min				
	Measure post retention force.				
hormal Shock No physical damage that would impair					
product performance.  but tit tr  N a	EIA-364-32, Method A, Test Condition I Subject mated specimens to 25 cycles between –55°C and 85°C with 30 minute dwellime at temperature extremes and 5 minute transition (maximum) between temperatures. Measurements to be recorded after specimens are held for 3 hours at ambient temperature and humidity.				
Humidity-Temperature Cycling No physical damage that would impair E	EIA-364-31, Method IV				
product performance.	Subject mated specimen to 10 cycles between 25°C and 65°C at 80-98% RH.				
a a	Measurements to be recorded after specimens are held for 3 hours at ambient temperature and humidity.				
	1 cycle is 24 hours.				
and strategic st	EIA-364-26, Condition B				
Figure 1 (continued)	EIA-364-26, Condition B Subject mated connectors to 5±1% salt				

Figure 1 (continued)

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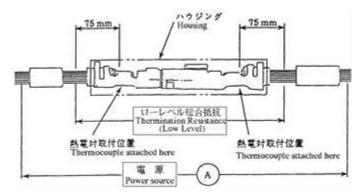


Temperature Life	No physical damage that would impair product performance.	EIA-364-17, Method A, Test Condition A, Test Condition 4				
		Subject mated connector to 105°C for a duration of 96 hours.				
		Measurements to be recorded after specimens are held for 3 hours at ambient temperature and humidity.				
Resistance to Cold	No physical damage that would impair product performance.	IEC 60512-11-10				
	product portormanos.	Subject mated connector to –30°C ± 2°C for 96 hours.				
Solderability	Wet Solder Coverage: 90% (minimum)	MIL-STD-202 Method 208				
		Solder Temperature: 245±5°C				
		Immersion Duration: 3±0.5 seconds				
Resistance to Soldering Heat	No physical damage that would impair	TE Spec. 109-202 Condition C				
	product performance.	Solder Temperature: 260 +0/-5°C				
		Immersion Duration: 5 +2/-0 Sec				
Hydrogen Sulfide	No physical damage that would impair product performance.	Subject mated specimens to $3 \pm 1$ ppm H <sub>2</sub> S gas concentration maintained at $40 \pm 2^{\circ}$ C for 96 hours.				
Ammonia	No physical damage that would impair product performance.	Subject mated specimens in atmosphere that rated 25 mL/L of 3% NH <sub>3</sub> for 7 hours.				

Figure 1 (end)



Shall meet visual requirements, show no physical damage, and meet requirements of additional tests as specified in the Product Qualification and Requalification Test Sequence shown in Figure 9.



**Figure 2:** Termination Resistance Measurement Points and Temperature Rise Set-up for Wire to Wire Configuration

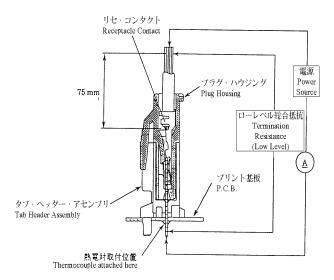
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# NOTE

Subtract the bulk resistance of the 150 mm wire leads from the final measurement.

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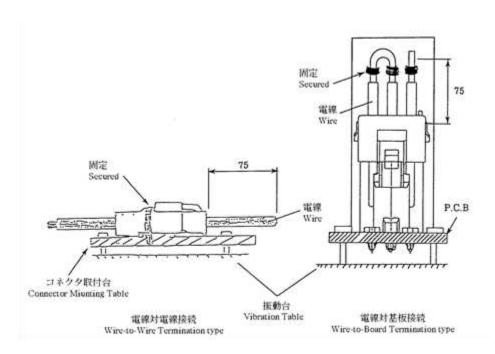


**Figure 3:** Termination Resistance Measurement Points and Temperature Rise Set-up for Wire to Board Configuration

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# NOTE

Subtract the bulk resistance of the 75 mm wire leads from the final measurement.



**Figure 4:** Connector Mounting Methods of Low Frequency Vibration and Mechanical Shock Tests

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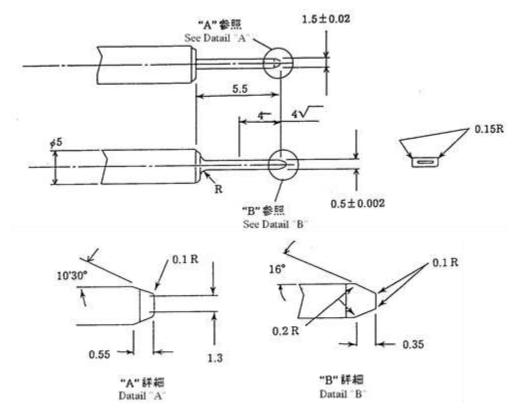


Figure 5: Gage Design for Contact Mating/Unmating Force Testing

	· ·	Contact: 177915 177917-1, 17791	•	Receptacle Contact: 177914-* Tab Contact: 177916-1					
Position	16 AWG	18 AWG	20 AWG	22 AWG	24 AWG	26 AWG			
1P-2P	14 A	8 A	7 A	5 A	4 A	3 A			
3P	9 A	7 A	6 A	4 A	3 A	2 A			
4P	9 A	7 A	6 A	4 A	3 A	2 A			
6P	8 A	6 A	5 A	3 A	2 A	2 A			
8P	8 A	6 A	5 A	3 A	2 A	2 A			
9P	8 A	6 A	5 A	3 A	2 A	2 A			
10P	7 A	5 A	4 A	2 A	2 A	2 A			
12P	7 A	5 A	4 A	2 A	2 A	2 A			

Figure 6



These currents are expected to produce an initial 30°C temperature rise (maximum) at the contacts. The temperature rise at the end of consecutive sequential testing (i.e. humidity-temperature cycling, temperature life, and vibration) may be higher.

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	Receptacle C	ontact: 2323832 2369500	-1, 2232901-1, -1, 1-2232901-1	Receptacle Contact: 2232902-1, 2369501-1, 1-2232902-1								
	Tab Con	tact: 177917-1, 2 177917-2, 2	Tab Contact: 177916-1, 2369502-1									
	Header Tab Contact: X-179863-2											
Position	16 AWG	18 AWG	20 AWG	22 AWG	24 AWG	26 AWG						
1P-2P	12 A	8 A	7 A	5 A	4 A	3 A						
3P	9 A	7 A	6 A	4 A	3 A	2 A						
4P	9 A	7 A	6 A	4 A	3 A	2 A						
6P	8 A	6 A	5 A	3 A	2 A	2 A						
8P	8 A	6 A	5 A	3 A	2 A	2 A						
9P	8 A	8 A 6 A		3 A	2 A	2 A						
10P	7 A	5 A	4 A	2 A	2 A	2 A						
12P	7 A	5 A	4 A	2 A	2 A 2 A							

Figure 7



These currents are expected to produce an initial 30°C temperature rise (maximum) at the contacts. The temperature rise at the end of consecutive sequential testing (i.e. humidity-temperature cycling, temperature life, and vibration) may be higher.

	Receptacle Contact: 2232901-2 Tab Contact: 177917-3									
Position	16 AWG	18 AWG	20 AWG							
1P-2P	14 A	9.3 A	8.1 A							
3P	10.5 A	8.1 A	7 A							
4P	10.5 A	8.1 A	7 A							
6P	9.3 A	7 A	5.8 A							
8P	9.3 A	7 A	5.8 A							
9P	9.3 A	7 A	5.8 A							
10P	8 A	5.8 A	4.6 A							
12P	8 A	5.8 A	4.6 A							

Figure 8



## NOTE

These currents are expected to produce a final (at the end of consecutive testing, i.e humidity-temperature cycling, temperature life, and vibration) 30°C temperature rise (maximum) at the contacts.

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		eceptacle Conta 1, 1-2232901-1, 2	Receptacle Contact: 2232902-1, 1-2232902-1, 2369501-1,							
	Header Tab Contact: X-2404337-2									
Position	16 AWG	18 AWG	20 AWG	22 AWG	24 AWG	26 AWG				
2P	10 A	8 A	7 A	5 A	4 A	3 A				
3-4P	9 A	7 A	6 A	4 A	3 A	2 A				
6P	8 A	5 A	5 A	3 A	2 A	2 A				

Figure 12



These currents are expected to produce an initial 30°C temperature rise (maximum) at the contacts. The temperature rise at the end of consecutive sequential testing (i.e. humidity-temperature cycling, temperature life, and vibration) may be higher.

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### Product Qualification and Requalification Test Sequence 3.6.

	TEST GROUP (a)																		
TEST OR	1	2	3	4	5	6	7(c)	8	9	10	11	12	13	14	15	16	17	18	19(d)
EXAMINATION		TEST SEQUENCE (b)																	
Examination of Product	1, 3	1, 4	1, 4	1	1, 3	1, 4	1, 7	1, 7	1, 4	1, 4	1, 4	1, 4	1, 4	1, 4	1, 4	1, 3	1, 3	1, 3	1, 9
Termination Resistance (Low Level)							2, 4, 6	3, 6	2, 5	2, 5	2, 5	2, 5	2, 5	2, 5	2, 5				2, 7
Dielectric Withstanding Voltage						3				7									
Insulation Resistance						2				6									
Temperature Rise					2														3, 8
Sinusoidal Vibration							5												
Mechanical Shock							3												
Connector Mating Force								2											
Connector Unmating Force								4											
Contact Insertion Force				2															
Contact Mating Force		2																	
Contact Unmating Force		3																	
Crimp Tensile Strength	2																		
Durability								5											
Housing Panel Retention Force			2																
Housing Locking Strength			3																
Post Retention Force																2			
Solderability																	2		
Ammonia															3				
Humidity-Temperature Cycling										3									4
Hydrogen Sulfide														3					
Resistance to Soldering Heat																		2	
Thermal Shock									3										
Salt Spray											3								
Resistance to Cold													3						
Contact Retention Force				3															
Temperature Life												3							5
Random Vibration																			6

Figure 9



# NOTE

- (a) See paragraph 4.2.(b) Numbers indicate sequence in which tests are performed.

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- (c) Perform test group on all contacts except part number 2232901-2 and 177917-3.
- (d) Perform test group only on contact part numbers 2232901-2 and 177917-3.

### 4. QUALITY ASSURANCE PROVISIONS

### 4.1. Test Conditions

Unless otherwise specified, all the tests shall be performed in any combination of the following test conditions shown in Figure 10.

Temperature	15°C – 35°C	
Relative Humidity	45% – 75%	
Atmospheric Pressure	86.6 – 106.6 kPa	

Figure 10

# 4.2. Qualification Testing

## A. Specimen Selection

Specimens shall be prepared in accordance with applicable instruction sheets and shall be selected at random from current production. The wires used for crimping samples for qualification testing shall conform to the requirements specified in Figure 11.

Wire Size (AWG [mm²])	Diameter of a Conductor (mm)	Number of Conductors	Insulation Outer Diameter (mm)
26 [0.14]	0.16	7	1.30
24 [0.22]	0.16	11	1.5
22 [0.31]	0.18	12	2.0
20 [0.51]	0.18	20	2.6
18 [0.76]	0.18	30	2.8
16 [1.27]	0.18	50	3.1

Figure 11

### B. Test Sequence

Qualification inspection shall be verified by testing specimens as specified in Figure 9.

### 4.3. Regualification Testing

If changes significantly affecting form, fit or function are made to the product or manufacturing process, product assurance shall coordinate requalification testing, consisting of all or part of the original testing sequence as determined by development/product, quality and reliability engineering.

## 4.4. Acceptance

Acceptance is based on verification that the product meets the requirements in Figure 1. Failures attributed to equipment, test setup or operator deficiencies shall not disqualify the product. If product failure occurs, corrective action shall be taken and specimens resubmitted for qualification. Testing to confirm corrective action is required before resubmittal.

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# 4.5. Quality Conformance Inspection

The applicable quality inspection plan shall specify the sampling acceptable quality level to be used. Dimensional and functional requirements shall be in accordance with the applicable product drawing and this specification.

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